

### General Description

The WSD3055GDN56 is the highest performance SGT Dual N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD3055GDN56 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

### Features

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

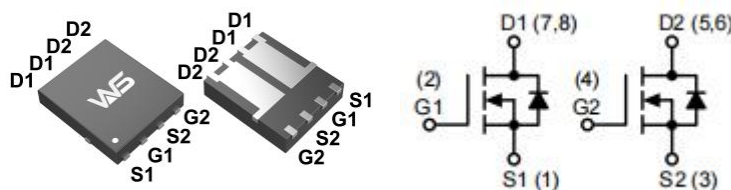
### Product Summary

| $BV_{DSS}$ | $R_{DS(ON)}$ | $I_D$ |
|------------|--------------|-------|
| 30V        | 5.5mΩ        | 45A   |

### Applications

- Power Management for Industrial DC/DC Converters
- Ideal for high-frequency switching and synchronous rectification

### DFN5\*6-8L Pin Configuration



### Absolute Maximum Ratings ( $T_A=25^{\circ}\text{C}$ , Unless Otherwise Noted)

| Symbol                         | Parameter                              |                           | Rating     | Units                |
|--------------------------------|----------------------------------------|---------------------------|------------|----------------------|
| $V_{DS}$                       | Drain-Source Voltage                   |                           | 30         | V                    |
| $V_{GS}$                       | Gate-Source Voltage                    |                           | $\pm 20$   |                      |
| $I_D$ <sup>7</sup>             | Continuous Drain Current               | $T_C=25^{\circ}\text{C}$  | 45         | A                    |
|                                |                                        | $T_C=100^{\circ}\text{C}$ | 30         |                      |
| $I_{DM}$ <sup>3</sup>          | Pulse Drain Current                    |                           | 90         |                      |
| $P_D$ <sup>2</sup>             | Power Dissipation                      | $T_C=25^{\circ}\text{C}$  | 27         | W                    |
| $I_{AS}$ <sup>3</sup>          | Single pulse Avalanche Current         |                           | 60         | A                    |
| $E_{AS}$ <sup>3</sup>          | Single pulse Avalanche Energy          | $L=0.5\text{mH}$          | 90         | mJ                   |
| $T_{STG}$                      | Storage Temperature Range              |                           | -55 to 150 | $^{\circ}\text{C}$   |
| $T_J$                          | Operating Junction Temperature Range   |                           | -55 to 150 |                      |
| $R_{\theta JA}$ <sup>1,4</sup> | Thermal Resistance-Junction to Ambient | $t \leq 10\text{s}$       | 30         | $^{\circ}\text{C/W}$ |
|                                |                                        | Steady State              | 60.5       |                      |
| $R_{\theta JC}$                | Thermal Resistance-Junction to Case    |                           | 3.1        |                      |

**Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)**

| Symbol       | Parameter                         | Conditions                                                                  | Min. | Typ. | Max.      | Units      |
|--------------|-----------------------------------|-----------------------------------------------------------------------------|------|------|-----------|------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage    | $V_{GS}=0V$ , $I_D=250\mu A$                                                | 30   | ---  | ---       | V          |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=10V$ , $I_D=20A$                                                    | ---  | 5.5  | 6.3       | m $\Omega$ |
|              |                                   | $T_J=125^{\circ}\text{C}$                                                   | ---  | 11   | ---       |            |
|              |                                   | $V_{GS}=4.5V$ , $I_D=15A$                                                   | ---  | 6.0  | 7.4       |            |
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{GS}=V_{DS}$ , $I_D=250\mu A$                                            | 1.0  | 1.4  | 2.0       | V          |
| $I_{DSS}$    | Drain-Source Leakage Current      | $V_{DS}=30V$ , $V_{GS}=0V$                                                  | ---  | ---  | 1.0       | $\mu A$    |
|              |                                   | $T_J=55^{\circ}\text{C}$                                                    | ---  | ---  | 5.0       |            |
| $I_{GSS}$    | Gate-Source Leakage Current       | $V_{DS}=0V$ , $V_{GS}=\pm 10V$                                              | ---  | ---  | $\pm 100$ | nA         |
| $g_{fs}$     | Forward Transconductance          | $V_{DS}=5V$ , $I_D=20A$                                                     | ---  | 30   | ---       | S          |
| $R_G$        | Gate Resistance                   | $f=1.0\text{MHz}$                                                           | 1.0  | 2.0  | 3.0       | $\Omega$   |
| $Q_g$        | Total Gate Charge (10V)           | $V_{DS}=15V$ , $V_{GS}=10V$ , $I_D=20A$                                     | ---  | 15   | ---       | nC         |
| $Q_{gs}$     | Gate-Source Charge                |                                                                             | ---  | 2.9  | ---       |            |
| $Q_{gd}$     | Gate-Drain Charge                 |                                                                             | ---  | 2.1  | ---       |            |
| $T_{d(on)}$  | Turn-On Delay Time                | $V_{DD}=5V$ , $V_{GS}=10V$ , $I_D=20A$<br>$R_L=1\Omega$ , $R_{GEN}=3\Omega$ | ---  | 6.5  | ---       | ns         |
| $T_r$        | Rise Time                         |                                                                             | ---  | 2.5  | ---       |            |
| $T_{d(off)}$ | Turn-Off Delay Time               |                                                                             | ---  | 17   | ---       |            |
| $T_f$        | Fall Time                         |                                                                             | ---  | 2.3  | ---       |            |
| $C_{iss}$    | Input Capacitance                 | $V_{DS}=15V$ , $V_{GS}=0V$ , $f=1.0\text{MHz}$                              | ---  | 780  | ---       | pF         |
| $C_{oss}$    | Output Capacitance                |                                                                             | ---  | 220  | ---       |            |
| $C_{rss}$    | Reverse Transfer Capacitance      |                                                                             | ---  | 15.3 | ---       |            |

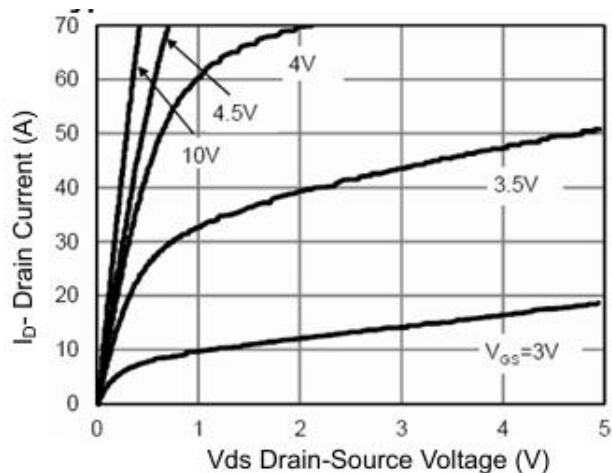
**Diode Characteristics**

| Symbol             | Parameter                 | Conditions                     | Min. | Typ. | Max. | Units |
|--------------------|---------------------------|--------------------------------|------|------|------|-------|
| $I_S$ <sup>7</sup> | Continuous Source Current |                                | ---  | ---  | 45   | A     |
| $V_{SD}$           | Diode Forward Voltage     | $V_{GS}=0V$ , $I_S=1A$         | ---  | 0.7  | 1.2  | V     |
| $t_{rr}$           | Reverse Recovery Time     | $I_F=20A$ , $di/dt=500A/\mu s$ | ---  | 10   | ---  | ns    |
| $Q_{rr}$           | Reverse Recovery Charge   |                                | ---  | 19   | ---  | nC    |

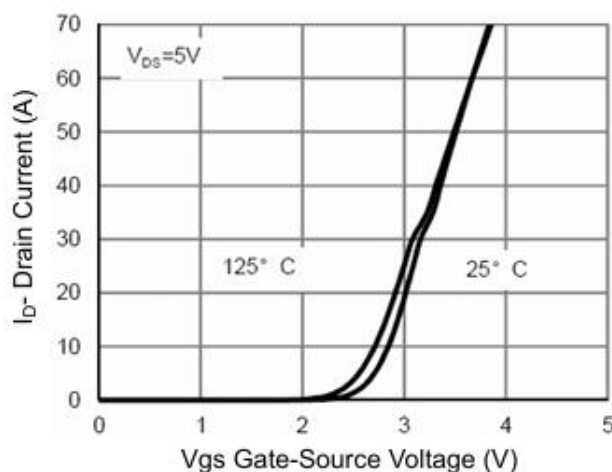
**Note:**

- The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10s$  and the maximum allowed junction temperature of  $150^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.
- The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- Single pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ .
- The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.
- The maximum current rating is package limited.
- These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ .
- The maximum current rating is silicon limited

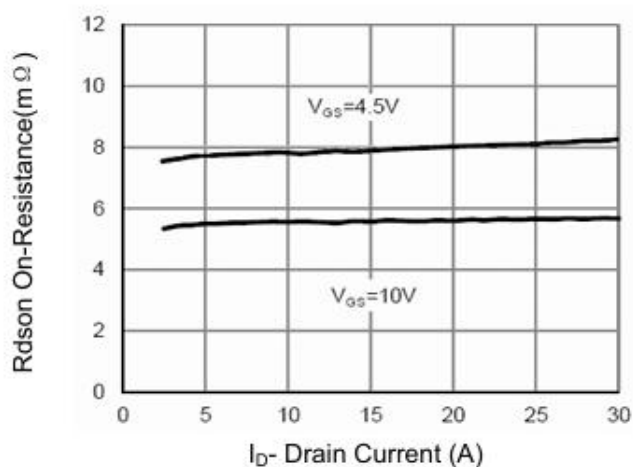
## Typical Characteristics



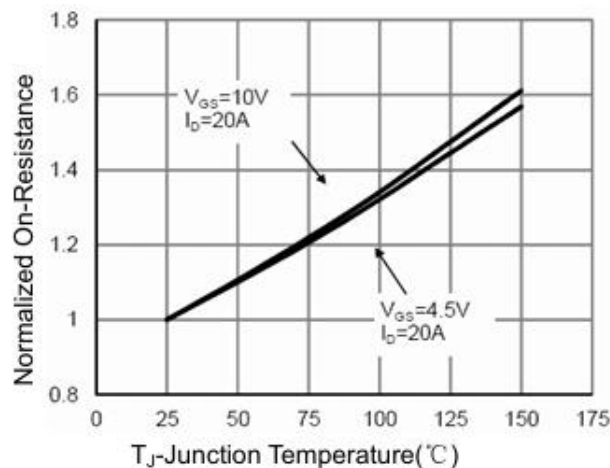
**Figure 1 Output Characteristics**



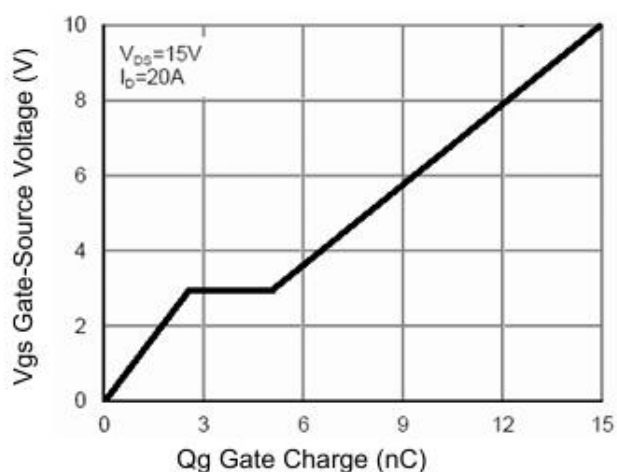
**Figure 2 Transfer Characteristics**



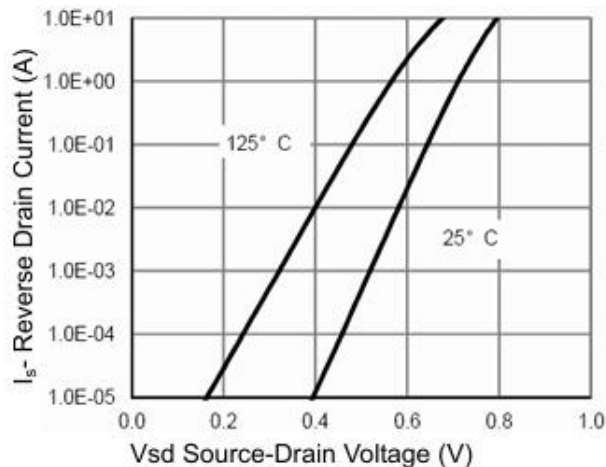
**Figure 3  $R_{DS(on)}$ - Drain Current**



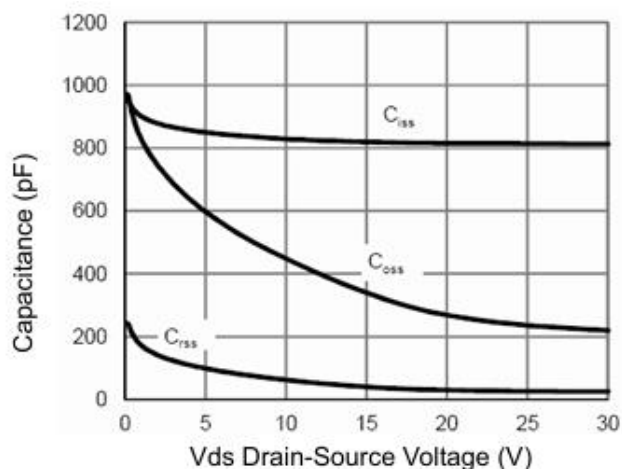
**Figure 4  $R_{DS(on)}$ -Junction Temperature**



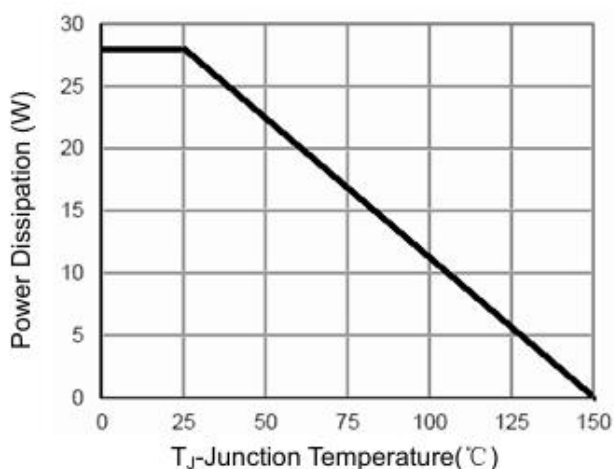
**Figure 5 Gate Charge**



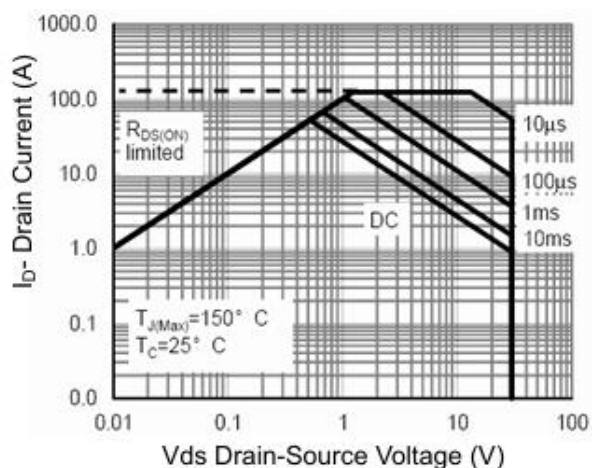
**Figure 6 Source- Drain Diode Forward**



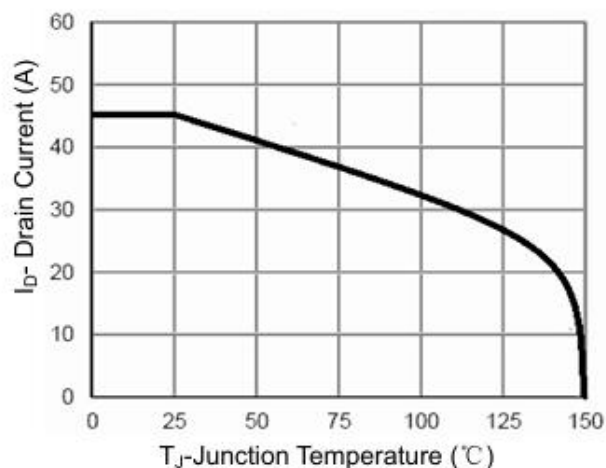
**Figure 7 Capacitance vs Vds**



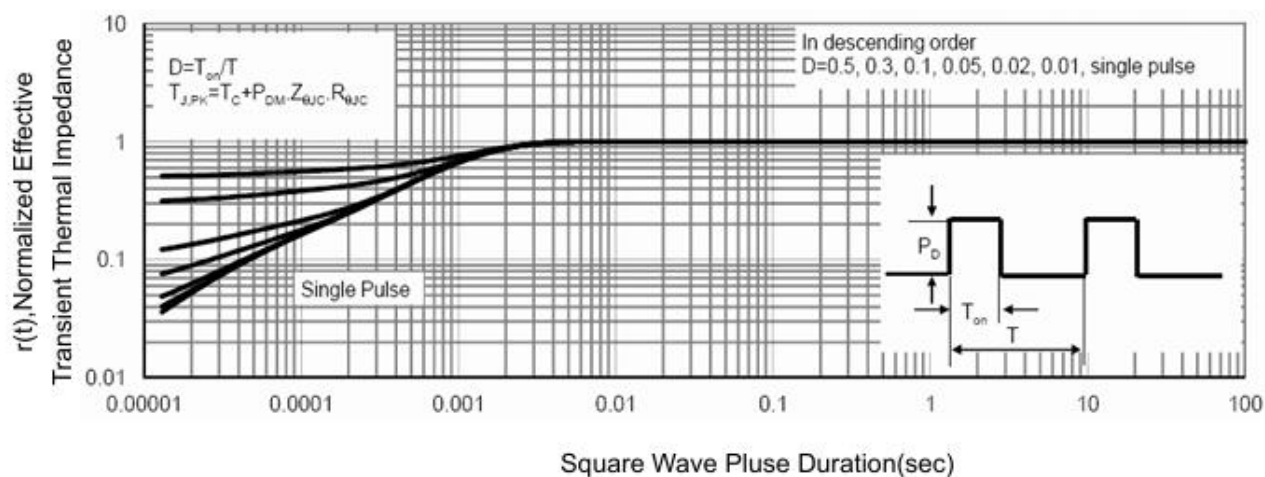
**Figure 9 Power De-rating**



**Figure 8 Safe Operation Area**

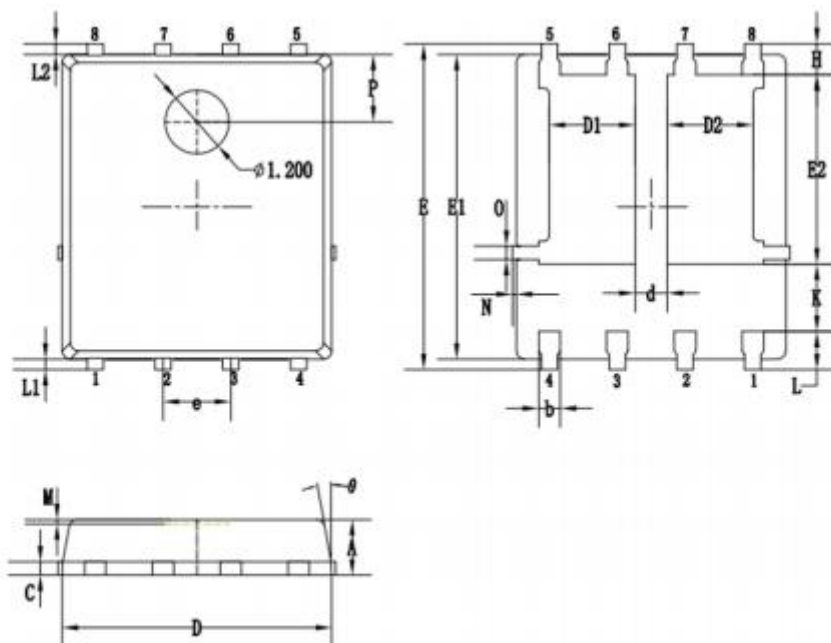


**Figure 10 Current De-rating**



**Figure 11 Normalized Maximum Transient Thermal Impedance**

## Packaging information



| SYMBOLS | MILLIMETERS |      |      |
|---------|-------------|------|------|
|         | MIN.        | NOM. | MAX. |
| A       | 0.90        | 1.05 | 1.20 |
| b       | 0.35        | 0.40 | 0.50 |
| C       | 0.20        | 0.25 | 0.35 |
| D       | 4.90        | 5.05 | 5.20 |
| D1/D2   | 1.51        | 1.61 | 1.71 |
| d       | 0.50        | 0.60 | 0.70 |
| E       | 6.00        | 6.15 | 6.30 |
| E1      | 5.60        | 5.75 | 5.90 |
| E2      | 3.47        | 3.57 | 3.67 |
| e       | 1.27 BSC.   |      |      |
| H       | 0.48        | 0.58 | 0.68 |
| K       | 1.17        | 1.27 | 1.37 |
| L       | 0.64        | 0.74 | 0.84 |
| L1/L2   | 0.20 REF.   |      |      |
| θ       | 8°          | 10°  | 12°  |
| M       | 0.08 REF.   |      |      |
| N       | 0           | -    | 0.15 |
| O       | 0.25 REF.   |      |      |
| P       | 1.28 REF.   |      |      |

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